

## GI15N03

### N-CHANNEL ENHANCEMENT MODE POWER MOSFET

BVDSS	30V
RDS(ON)	80mΩ
ID	15A

### Description

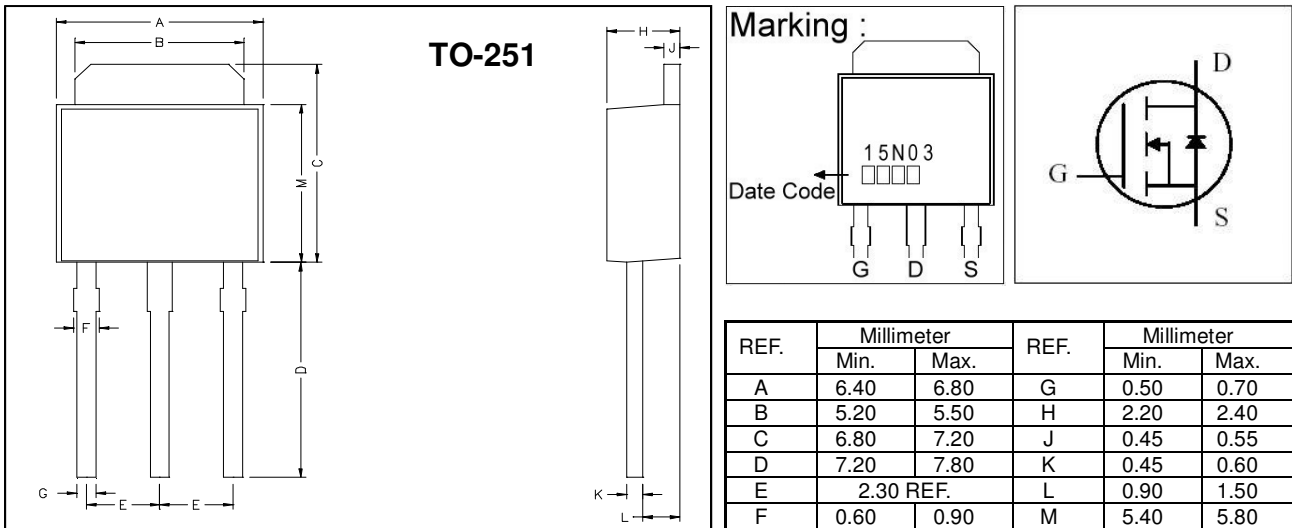
The GI15N03 provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The through-hole version (TO-251) is available for low-profile applications and suited for low voltage applications such as DC/DC converters.

### Features

- \*Dynamic dv/dt Rating
- \*Simple Drive Requirement
- \*Repetitive Avalanche Rated
- \*Fast Switching

### Package Dimensions



### Absolute Maximum Ratings

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	$V_{DS}$	30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current, $V_{GS}@10V$	$I_D @T_C=25^\circ C$	15	A
Continuous Drain Current, $V_{GS}@10V$	$I_D @T_C=100^\circ C$	9	A
Pulsed Drain Current <sup>1</sup>	$I_{DM}$	50	A
Total Power Dissipation	$P_D @T_C=25^\circ C$	28	W
Linear Derating Factor		0.22	W/ $^\circ C$
Operating Junction and Storage Temperature Range	$T_j, T_{stg}$	-55 ~ +150	$^\circ C$

### Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance Junction-case Max.	Rthj-c	4.5	$^\circ C/W$
Thermal Resistance Junction-ambient Max.	Rthj-a	110	$^\circ C/W$

**Electrical Characteristics (T<sub>j</sub> = 25°C unless otherwise specified)**

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	30	-	-	V	V <sub>GS</sub> =0, I <sub>D</sub> =250uA
Breakdown Voltage Temperature Coefficient	$\Delta BV_{DSS} / \Delta T_j$	-	0.037	-	V/°C	Reference to 25°C, I <sub>D</sub> =1mA
Gate Threshold Voltage	V <sub>GS(th)</sub>	1.0	-	3.0	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA
Forward Transconductance	I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> = ±20V
Drain-Source Leakage Current(T <sub>j</sub> =25°C)	I <sub>DSS</sub>	-	-	25	uA	V <sub>DS</sub> =30V, V <sub>GS</sub> =0
Drain-Source Leakage Current(T <sub>j</sub> =150°C)		-	-	250	uA	V <sub>DS</sub> =24V, V <sub>GS</sub> =0
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	-	-	80	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> =8A
		-	-	100		V <sub>GS</sub> =4.5V, I <sub>D</sub> =6A
Total Gate Charge <sup>2</sup>	Q <sub>g</sub>	-	5.4	-	nC	I <sub>D</sub> =8A V <sub>DS</sub> =24V V <sub>GS</sub> =5V
Gate-Source Charge	Q <sub>gs</sub>	-	1.3	-		
Gate-Drain ("Miller") Change	Q <sub>gd</sub>	-	3.6	-		
Turn-on Delay Time <sup>2</sup>	T <sub>d(on)</sub>	-	3.6	-	ns	V <sub>DS</sub> =15V I <sub>D</sub> =8A V <sub>GS</sub> =10V R <sub>G</sub> =3.3Ω R <sub>D</sub> =1.9Ω
Rise Time	T <sub>r</sub>	-	19.8	-		
Turn-off Delay Time	T <sub>d(off)</sub>	-	13	-		
Fall Time	T <sub>f</sub>	-	3.2	-		
Input Capacitance	C <sub>iss</sub>	-	260	-	pF	V <sub>GS</sub> =0V V <sub>DS</sub> =25V f=1.0MHz
Output Capacitance	C <sub>oss</sub>	-	144	-		
Reverse Transfer Capacitance	C <sub>rss</sub>	-	13	-		

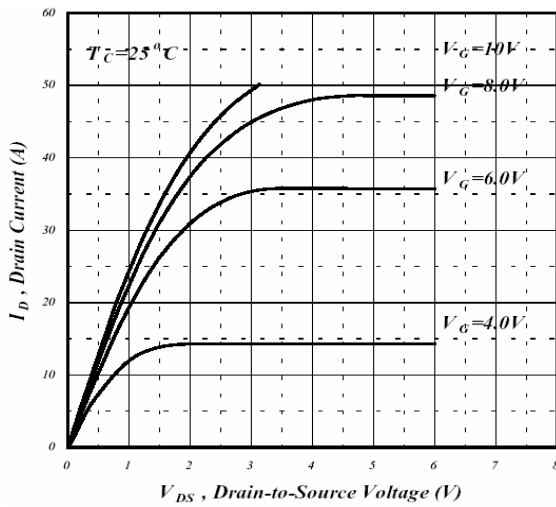
**Source-Drain Diode**

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Forward On Voltage <sup>2</sup>	V <sub>SD</sub>	-	-	1.3	V	I <sub>S</sub> =15A, V <sub>GS</sub> =0V, T <sub>j</sub> =25°C
Continuous Source Current(Body Diode)	I <sub>S</sub>	-	-	15	A	V <sub>D</sub> =V <sub>G</sub> =0V, V <sub>S</sub> =1.3V
Pulsed Source Current(Body Diode) <sup>1</sup>	I <sub>SM</sub>	-	-	50	A	

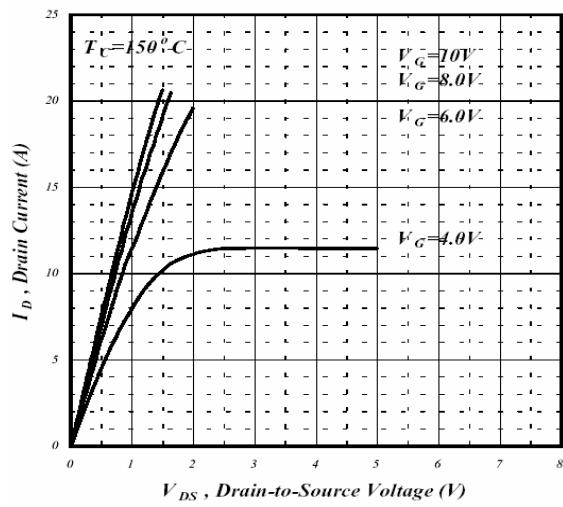
Notes: 1. Pulse width limited by safe operating area.

2. Pulse width ≤ 300us, duty cycle ≤ 2%.

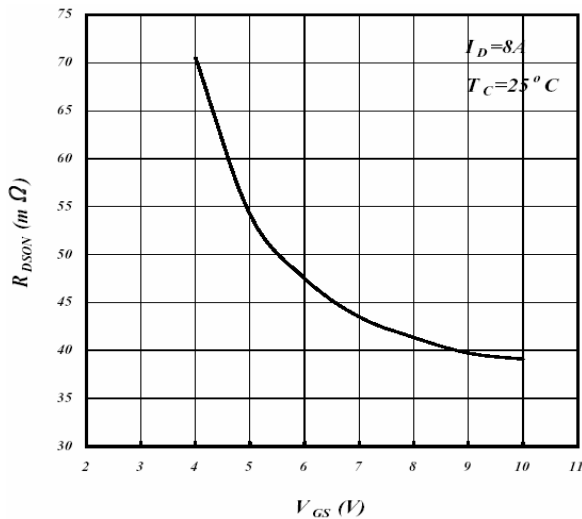
## Characteristics Curve



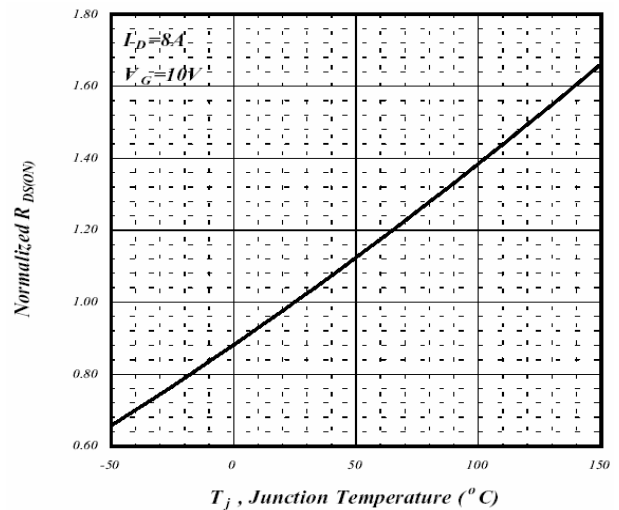
**Fig 1. Typical Output Characteristics**



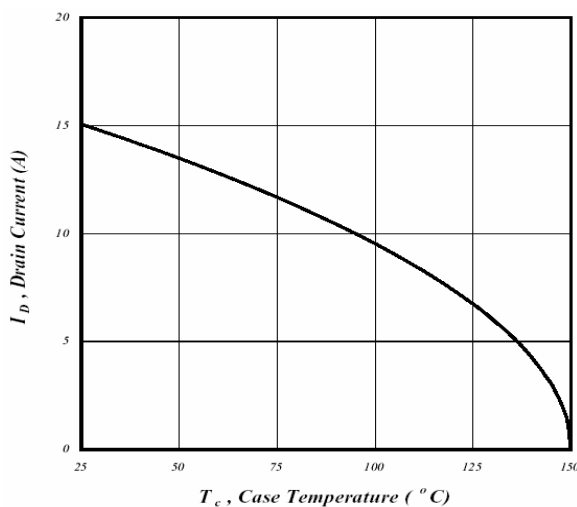
**Fig 2. Typical Output Characteristics**



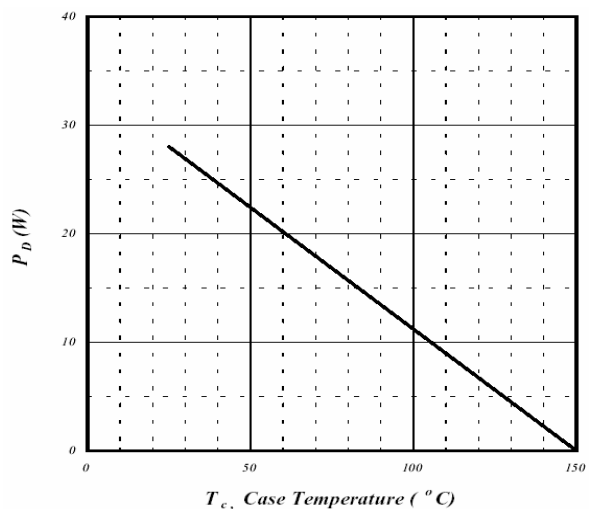
**Fig 3. On-Resistance v.s. Gate Voltage**



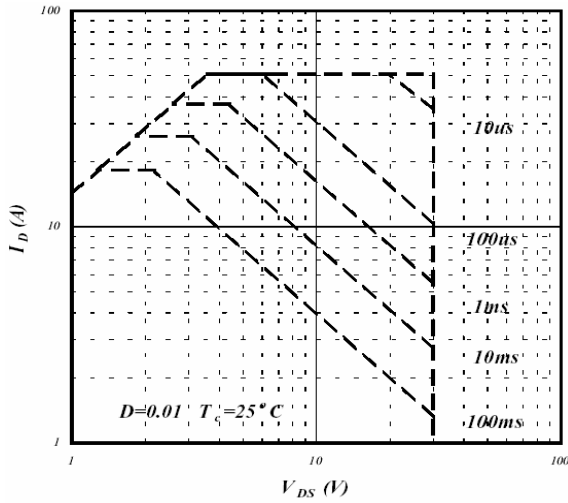
**Fig 4. Normalized On-Resistance v.s. Junction Temperature**



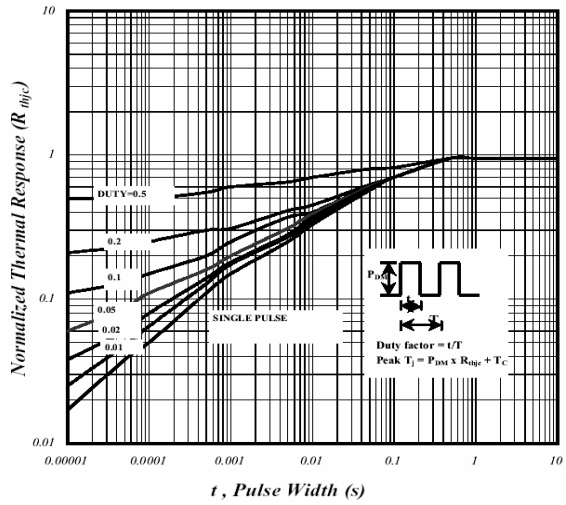
**Fig 5. Maximum Drain Current v.s. Case Temperature**



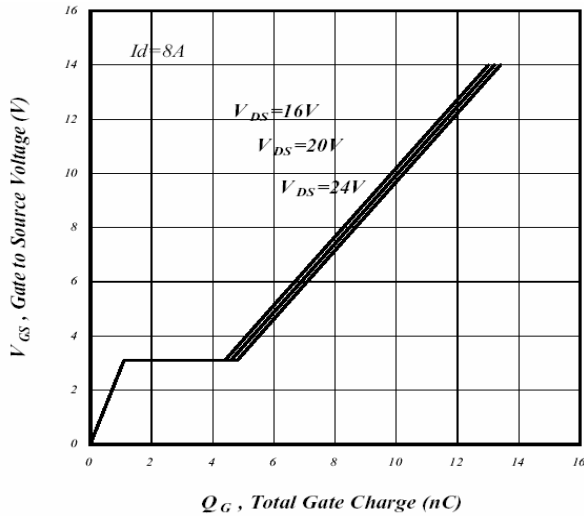
**Fig 6. Type Power Dissipation**



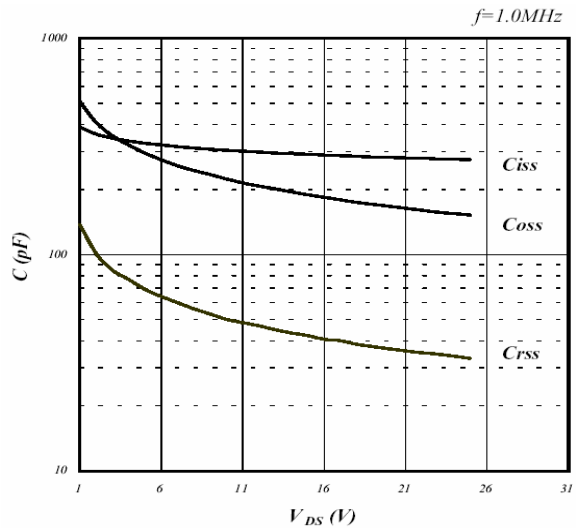
**Fig 7. Maximum Safe Operating Area**



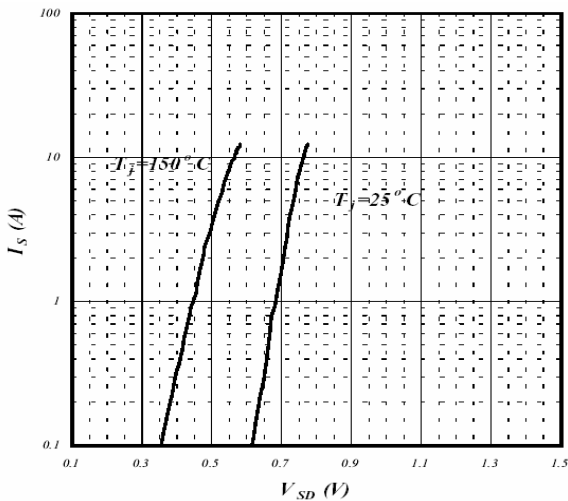
**Fig 8. Effective Transient Thermal Impedance**



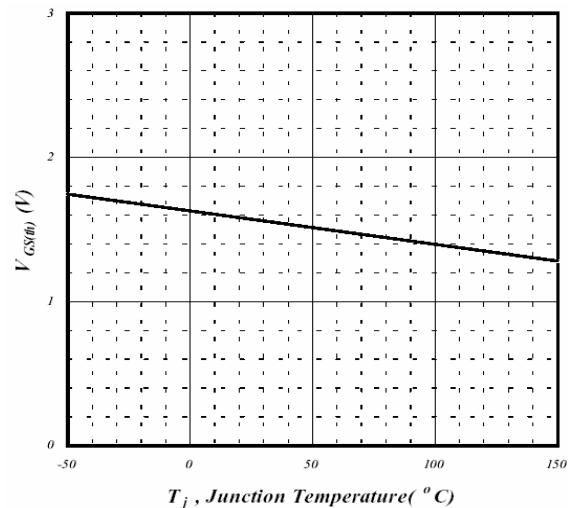
**Fig 9. Gate Charge Characteristics**



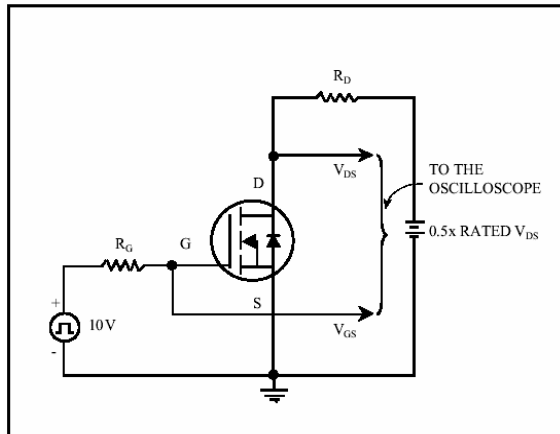
**Fig 10. Typical Capacitance Characteristics**



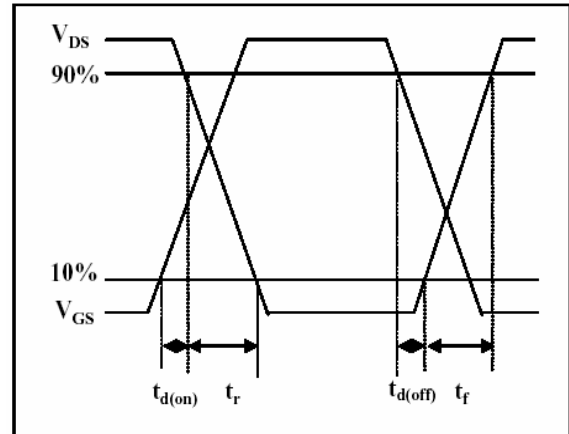
**Fig 11. Forward Characteristics of Reverse Diode**



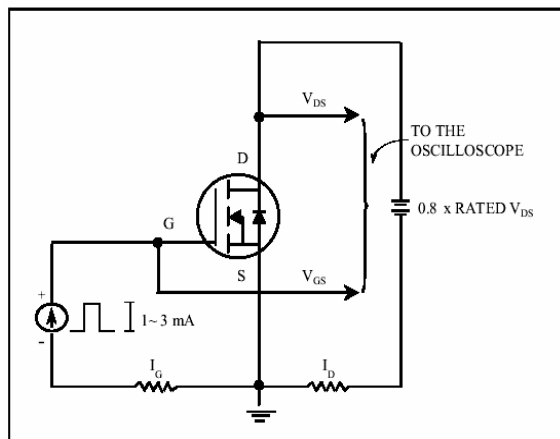
**Fig 12. Gate Threshold Voltage v.s. Junction Temperature**



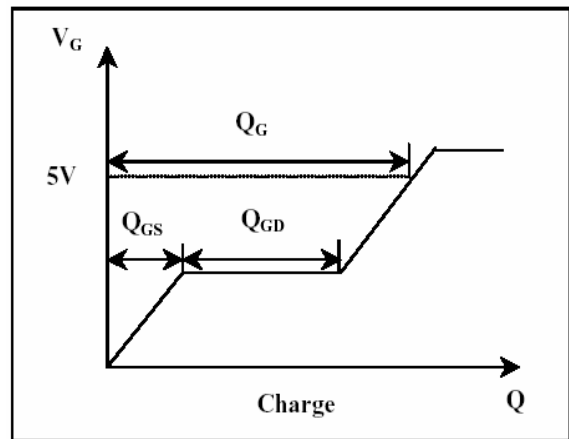
**Fig 13. Switching Time Circuit**



**Fig 14. Switching Time Waveform**



**Fig 15. Gate Charge Circuit**



**Fig 16. Gate Charge Waveform**

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